Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/721,786	JUN, JUNG SIG	
Examiner	Art Unit	
 Krista M. Flanagan	2631	

SEARCHED							
Class	Subclass	Date	Examiner				
375	326 316 321 350 261 340	5/26/2005	KMF				
348	325 725	5/26/2005	KMF				
348	726	5/26/2005	KMF				
329	304 306	5/26/2005	KMF				
329	307 308	5/26/2005	KMF				
375	270	5/26/2005	KMF				
329	357	5/26/2005	KMF				
, 375	327 355	5/26/2005	KMF				
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INT	INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
		DATE	EXMR	
EAST		5/26/2005	KMF	
Inventor Search		5/26/2005	KMF	
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